

#### **General Description**

The WST8205 is the highest performance trench N-ch MOSFET with extreme high cell density , which provide excellent RDSON and gate charge for most of the small power switching and load switch applications.

The WST8205 meet the RoHS and Green Product requirement with full function reliability approved.

#### Features

- Advanced high cell density Trench technology
- Super Low Gate Charge
- Excellent Cdv/dt effect decline
- Green Device Available

#### **Product Summery**

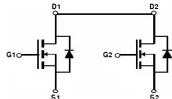
BVDSS	RDSON	ID
20V	24mΩ	5.8A

#### Applications

- High Frequency Point-of-Load Synchronous Small power switching for MB/NB/UMPC/VGA
- Networking DC-DC Power System

#### SOT-23-6L Pin Configuration





#### **Absolute Maximum Ratings**

Symbol	Parameter	Rating	Units	
V <sub>DS</sub>	Drain-Source Voltage	20	V	
V <sub>GS</sub>	Gate-Source Voltage	±12	V	
I <sub>D</sub> @T₀=25℃	Continuous Drain Current, V <sub>GS</sub> @ 4.5V <sup>1</sup> 5.8			
I <sub>D</sub> @T <sub>c</sub> =70℃	Continuous Drain Current, V <sub>GS</sub> @ 4.5V <sup>1</sup>	3.8	A	
I <sub>DM</sub>	Pulsed Drain Current <sup>2</sup> 16		A	
P <sub>D</sub> @T <sub>A</sub> =25℃	Total Power Dissipation <sup>3</sup> 2.1		W	
T <sub>STG</sub>	Storage Temperature Range -55 to 150		°C	
TJ	Operating Junction Temperature Range	-55 to 150	°C	

#### **Thermal Data**

Symbol	Parameter	Тур.	Max.	Unit
R <sub>θJA</sub>	Thermal Resistance Junction-ambient <sup>1</sup>		125	°C/W
R <sub>eJC</sub>	Thermal Resistance Junction-Case <sup>1</sup>		70	°C/W



### **WST8205**

#### **Dual N-Ch MOSFET**

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V , I <sub>D</sub> =250uA	20			V
$\triangle BV_{DSS} / \triangle T_J$	BVDSS Temperature Coefficient	Reference to $25^\circ C$ , I <sub>D</sub> =1mA		0.022		V/℃
Б	Static Drain-Source On-Resistance <sup>2</sup>	V <sub>GS</sub> =4.5V , I <sub>D</sub> =5.5A		24	28	mΩ
R <sub>DS(ON)</sub>		V <sub>GS</sub> =2.5V , I <sub>D</sub> =3.5A		30	45	
V <sub>GS(th)</sub>	Gate Threshold Voltage		0.5	0.7	1.2	V
$ riangle V_{GS(th)}$	V <sub>GS(th)</sub> Temperature Coefficient	$V_{GS}=V_{DS}$ , $I_D=250$ uA		-2.33		mV/℃
1	Drain-Source Leakage Current	V <sub>DS</sub> =16V , V <sub>GS</sub> =0V , T <sub>J</sub> =25℃			1	
I <sub>DSS</sub>		V <sub>DS</sub> =16V , V <sub>GS</sub> =0V , T <sub>J</sub> =55℃			5	uA
I <sub>GSS</sub>	Gate-Source Leakage Current	$V_{GS}=\pm12V$ , $V_{DS}=0V$			±100	nA
gfs	Forward Transconductance	V <sub>DS</sub> =5V , I <sub>D</sub> =5A		25		S
Rg	Gate Resistance	V <sub>DS</sub> =0V , V <sub>GS</sub> =0V , f=1MHz		1.5	3	Ω
Qg	Total Gate Charge (4.5V)	V <sub>DS</sub> =10V , V <sub>GS</sub> =4.5V , I <sub>D</sub> =5.5A		8.3	11.9	
Q <sub>gs</sub>	Gate-Source Charge			1.4	2.0	nC
Q <sub>gd</sub>	Gate-Drain Charge			2.2	3.2	
T <sub>d(on)</sub>	Turn-On Delay Time			5.7	11.6	
Tr	Rise Time	$V_{DD}$ =10V , $V_{GEN}$ =4.5V , RG=6 $\Omega$		34	63	ns
T <sub>d(off)</sub>	Turn-Off Delay Time	I <sub>D</sub> =5A, RL=10Ω		22	46	
T <sub>f</sub>	Fall Time			9.0	18.4	
Ciss	Input Capacitance	V <sub>DS</sub> =10V , V <sub>GS</sub> =0V , f=1MHz		625	889	
C <sub>oss</sub>	Output Capacitance			69	98	pF
C <sub>rss</sub>	Reverse Transfer Capacitance			61	88	

#### **Diode Characteristics**

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
ls	Continuous Source Current <sup>1,4</sup>				1.5	А
I <sub>SM</sub>	Pulsed Source Current <sup>2,4</sup>	V <sub>G</sub> =V <sub>D</sub> =0V , Force Current			16	А
V <sub>SD</sub>	Diode Forward Voltage <sup>2</sup>	V <sub>GS</sub> =0V , I <sub>S</sub> =1A , T <sub>J</sub> =25℃			1.2	V
t <sub>rr</sub>	Reverse Recovery Time			7.1		nS
Q <sub>rr</sub>	Reverse Recovery Charge	l <b>⊧=5A</b> , dl/dt=100A/μs , T <sub>J</sub> =25℃		1.8		nC

Note :

1. The data tested by surface mounted on a 1 inch<sup>2</sup> FR-4 board with 2OZ copper.

2.The data tested by pulsed , pulse width  $\leq 300 us$  , duty cycle  $\leq 2\%$  3.The power dissipation is limited by 150  $^\circ\!C$  junction temperature

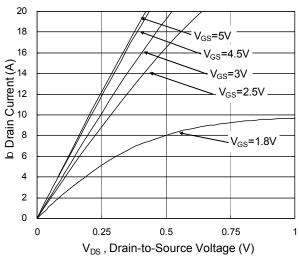
4. The data is theoretically the same as  $I_{\text{D}}$  and  $I_{\text{DM}}$  , in real applications , should be limited by total power dissipation.



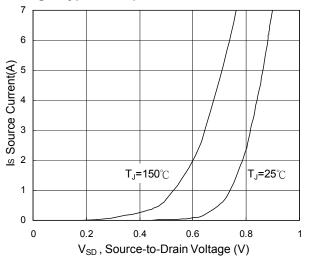
# WST8205

#### **Dual N-Ch MOSFET**





**Fig.1 Typical Output Characteristics** 





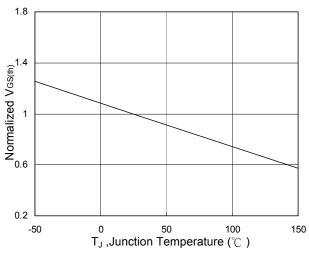


Fig.5 Normalized  $V_{GS(th)}$  vs. T<sub>J</sub>

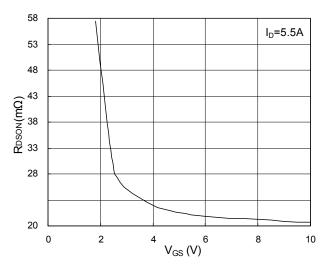


Fig.2 On-Resistance vs. Gate-Source

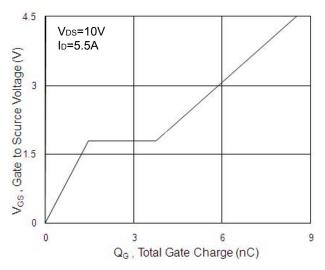


Fig.4 Gate-Charge Characteristics

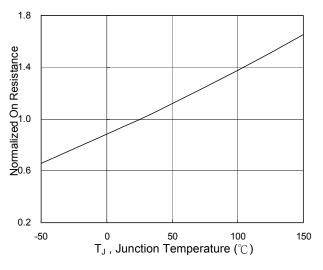
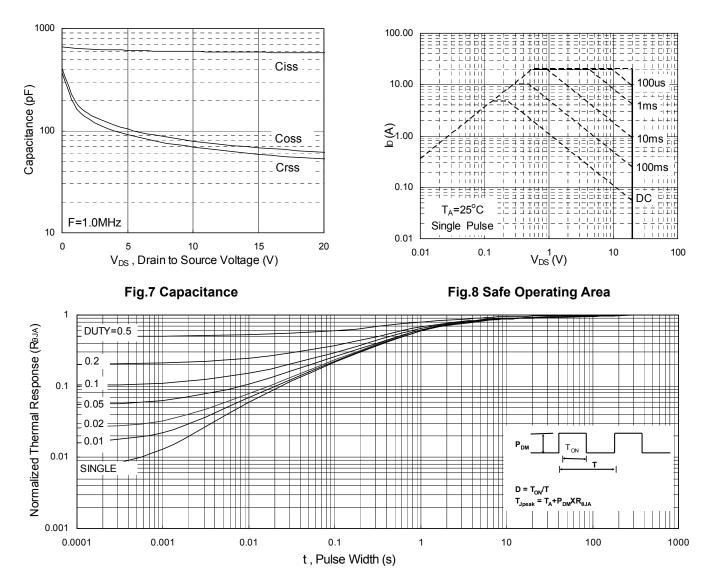


Fig.6 Normalized R<sub>DSON</sub> vs. T<sub>J</sub>

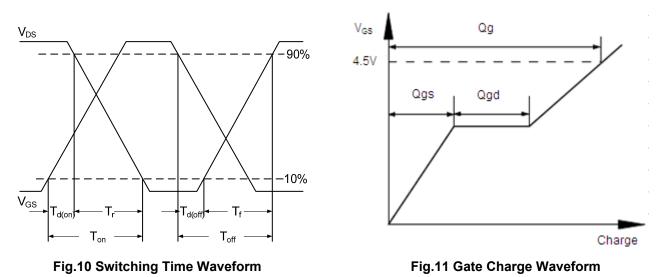


# WST8205

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